



RADIO TEST REPORT

Test Report No. : 13074034H-B

Applicant : Panasonic Avionics Corporation
Type of Equipment : BTv4.0 Dual Mode USB HCI Module
Model No. : R8U2FW6810Z
FCC ID : U6YBT800
Test regulation : FCC Part 15 Subpart C: 2019
For Permissive Change
* Bluetooth part
(Maximum Peak Output Power and Radiated Spurious Emission tests only)
Test Result : Complied (Refer to SECTION 3.2)

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
8. The information provided from the customer for this report is identified in SECTION 1.

Date of test: October 19 and 20, 2019

Representative test engineer: *T. Nakagawa*
Tomohisa Nakagawa
Engineer
Consumer Technology Division

Approved by: *Takayuki S.*
Takayuki Shimada
Leader
Consumer Technology Division



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
*As for the range of Accreditation in NVLAP, you may refer to the WEB address,
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- ☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.
☒ There is no testing item of "Non-accreditation".

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REVISION HISTORY

Original Test Report No.: 13074034H-B

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13074034H-B	November 11, 2019	-	-

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Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	MCS	Modulation and Coding Scheme
AC	Alternating Current	MRA	Mutual Recognition Arrangement
AFH	Adaptive Frequency Hopping	N/A	Not Applicable
AM	Amplitude Modulation	NIST	National Institute of Standards and Technology
Amp, AMP	Amplifier	NS	No signal detect.
ANSI	American National Standards Institute	NSA	Normalized Site Attenuation
Ant, ANT	Antenna	NVLAP	National Voluntary Laboratory Accreditation Program
AP	Access Point	OBW	Occupied Band Width
ASK	Amplitude Shift Keying	OFDM	Orthogonal Frequency Division Multiplexing
Atten., ATT	Attenuator	P/M	Power meter
AV	Average	PCB	Printed Circuit Board
BPSK	Binary Phase-Shift Keying	PER	Packet Error Rate
BR	Bluetooth Basic Rate	PHY	Physical Layer
BT	Bluetooth	PK	Peak
BT LE	Bluetooth Low Energy	PN	Pseudo random Noise
BW	BandWidth	PRBS	Pseudo-Random Bit Sequence
Cal Int	Calibration Interval	PSD	Power Spectral Density
CCK	Complementary Code Keying	QAM	Quadrature Amplitude Modulation
Ch., CH	Channel	QP	Quasi-Peak
CISPR	Comite International Special des Perturbations Radioelectriques	QPSK	Quadri-Phase Shift Keying
CW	Continuous Wave	RBW	Resolution Band Width
DBPSK	Differential BPSK	RDS	Radio Data System
DC	Direct Current	RE	Radio Equipment
D-factor	Distance factor	RF	Radio Frequency
DFS	Dynamic Frequency Selection	RMS	Root Mean Square
DQPSK	Differential QPSK	RSS	Radio Standards Specifications
DSSS	Direct Sequence Spread Spectrum	Rx	Receiving
EDR	Enhanced Data Rate	SA, S/A	Spectrum Analyzer
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	SG	Signal Generator
EMC	ElectroMagnetic Compatibility	SVSWR	Site-Voltage Standing Wave Ratio
EMI	ElectroMagnetic Interference	TR	Test Receiver
EN	European Norm	Tx	Transmitting
ERP, e.r.p.	Effective Radiated Power	VBW	Video BandWidth
EU	European Union	Vert.	Vertical
EUT	Equipment Under Test	WLAN	Wireless LAN
Fac.	Factor		
FCC	Federal Communications Commission		
FHSS	Frequency Hopping Spread Spectrum		
FM	Frequency Modulation		
Freq.	Frequency		
FSK	Frequency Shift Keying		
GFSK	Gaussian Frequency-Shift Keying		
GNSS	Global Navigation Satellite System		
GPS	Global Positioning System		
Hori.	Horizontal		
ICES	Interference-Causing Equipment Standard		
IEC	International Electrotechnical Commission		
IEEE	Institute of Electrical and Electronics Engineers		
IF	Intermediate Frequency		
ILAC	International Laboratory Accreditation Conference		
ISED	Innovation, Science and Economic Development Canada		
ISO	International Organization for Standardization		
JAB	Japan Accreditation Board		
LAN	Local Area Network		
LIMS	Laboratory Information Management System		

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SECTION 1: Customer information

Company Name	:	Panasonic Avionics Corporation
Address	:	26200 Enterprise Way Lake Forest, CA 92630 USA
Telephone Number	:	+1-949-672-2000
Facsimile Number	:	+1-949-462-7100
Contact Person	:	David O'Reilly

The information provided from the customer is as follows;

- Applicant, Type of Equipment, Model No., FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (E.U.T.)
- SECTION 4: Operation of E.U.T. during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	BTv4.0 Dual Mode USB HCI Module
Model No.	:	R8U2FW6810Z
Serial No.	:	Refer to SECTION 4.2
Rating	:	DC 5 V
Receipt Date of Sample (Information from test lab.)	:	October 16, 2019
Country of Mass-production	:	Japan
Condition of EUT	:	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab.

2.2 Product Description

Model: R8U2FW6810Z (referred to as the EUT in this report) is a BTv4.0 Dual Mode USB HCI Module.

Radio Specification

[Bluetooth (Dual mode (Classic Bluetooth and BT LE))]

Radio Type	:	Transceiver
Frequency of Operation	:	2402 MHz - 2480 MHz
Modulation	:	BT: FHSS (GFSK, $\pi/4$ DQPSK, 8DPSK) LE: GFSK
Channel spacing	:	BT: 1 MHz LE: 2 MHz
Power Supply (radio part input)	:	DC 3.3 V / DC 1.8 V
Antenna type	:	Pattern Antenna
Antenna Gain	:	2.5 dBi
Clock frequency (Maximum)	:	48 MHz

* This test report applies to Bluetooth with EDR function (2402 MHz - 2480 MHz) except for Bluetooth Low Energy.

<Contents of the change from original model>

Antenna gain is larger than original model and output power settings are lower than original model.

Therefore only Maximum Peak Output Power and Radiated Spurious Emission tests were performed in this report.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on July 19, 2019 and effective August 19, 2019 except 15.258

Title : FCC 47 CFR Part 15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz,
and 5725-5850 MHz

3.2 Procedures and results

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
Maximum Peak Output Power	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.12	FCC: Section15.247(a)(b)(1) ----- ISED: RSS-247 5.4 (b)	See data.	Complied a)	Conducted
Spurious Emission & Band Edge Compliance	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.13	FCC: Section15.247(d) ----- ISED: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	9.8 dB 2483.500 MHz, AV, Vertical	Complied b)	Radiated (above 30 MHz) *1)

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) Radiated test was selected over 30 MHz based on section 15.247(d).

a) Refer to APPENDIX 1 (data of Maximum Peak Output Power)

b) Refer to APPENDIX 1 (data of Radiated Spurious Emission)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

FCC Part 15.31 (e)

This EUT provides stable voltage (DC 3.3 V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

The antenna is not removable from the EUT.

Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k=2$.
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Antenna Terminal test

Test Item	Uncertainty (+/-)
20 dB Bandwidth / 99 % Occupied Bandwidth	0.96 %
Maximum Peak Output Power / Average Output Power	1.4 dB
Carrier Frequency Separation	0.42 %
Dwell time / Burst rate	0.10 %
Conducted Spurious Emission	2.6 dB

Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)
3 m	9 kHz to 30 MHz	3.3 dB
10 m		3.2 dB
3 m	30 MHz to 200 MHz (Horizontal) (Vertical)	4.8 dB
		5.0 dB
	200 MHz to 1000 MHz (Horizontal) (Vertical)	5.2 dB
		6.3 dB
10 m	30 MHz to 200 MHz (Horizontal) (Vertical)	4.8 dB
		4.8 dB
	200 MHz to 1000 MHz (Horizontal) (Vertical)	5.0 dB
		5.0 dB
3 m	1 GHz to 6 GHz	4.9 dB
	6 GHz to 18 GHz	5.2 dB
1 m	10 GHz to 26.5 GHz	5.5 dB
	26.5 GHz to 40 GHz	5.5 dB
10 m	1 GHz to 18 GHz	5.2 dB

3.5 Test Location

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*NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967 / ISED Lab Company Number: 2973C

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Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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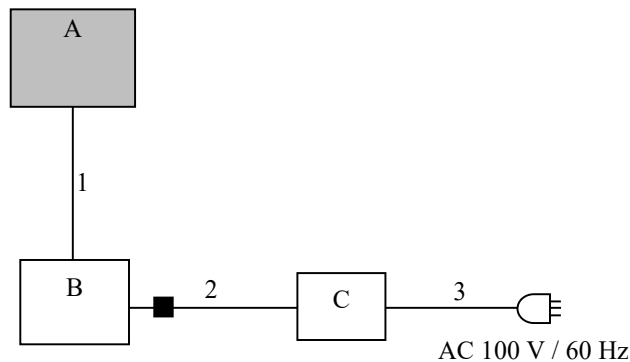
SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Bluetooth (BT): Transmitting (Tx), Payload: PRBS9

Test Item	Mode	Tested frequency
Radiated Spurious Emission	Tx (Hopping Off) DH5, 3DH5	2402 MHz 2441 MHz 2480 MHz
Maximum Peak Output Power	Tx (Hopping Off) DH5, 2DH5, 3DH5	2402 MHz 2441 MHz 2480 MHz
*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload length (except Dwell time test) *2DH mode (2Mb/s EDR: pi/4DQPSK) was excluded for other tests than power measurement by using 3DH mode (3 Mb/s EDR: 8DPSK) as a representative. * It is considered that the non-tested packet type (e.g. inquiry) can be omitted as it is complied with above all the test items based on Bluetooth Core specification. *Power of the EUT was set by the software as follows; Power settings: Ext: 255, Int: 36 Software: Blue test 3, Version 2.5.0.93 *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.		

4.2 Configuration and peripherals



■ : Standard Ferrite Core

* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	BluetoothBTv4.0 Dual Mode USB HCI Module	R8U2FW6810Z	527FC2 for AT* 527FF1 for RE*	Panasonic Corporation	EUT
B	Laptop PC	CF-SX2	4KSA78923	Panasonic Corporation	-
C	AC Adapter	CF-AA5773A	5713AM110209115A	Panasonic Corporation	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	USB Cable	3.3	Shielded	Shielded	-
2	DC Cable	1.8	Unshielded	Unshielded	-
3	AC Cable	1.5	Unshielded	Unshielded	-

*AT: Antenna Terminal conducted test, RE: Radiated Spurious Emission test

SECTION 5: Radiated Spurious Emission

Test Procedure

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

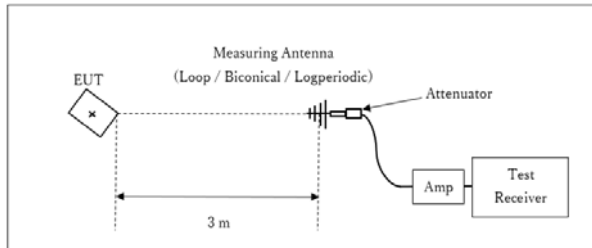
20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9 (ISED) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (ISED).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV *1)	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces Duty factor was added to the results.	RBW: 100 kHz VBW: 300 kHz

*1) Average Power Measurement was performed based on KDB 558074 D01 15.247 Meas Guidance v05r02.

Figure 2: Test Setup

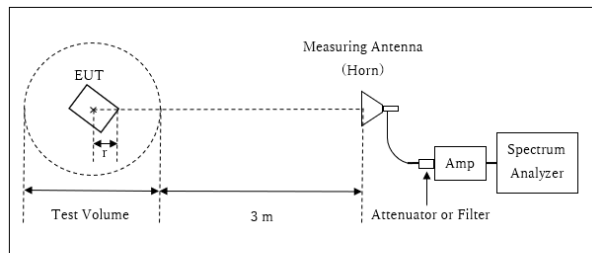
Below 1 GHz



x : Center of turn table

Test Distance: 3 m

1 GHz - 10 GHz



r : Radius of an outer periphery of EUT

x : Center of turn table

Distance Factor: $20 \times \log (4.0 \text{ m} / 3.0 \text{ m}) = 2.5 \text{ dB}$

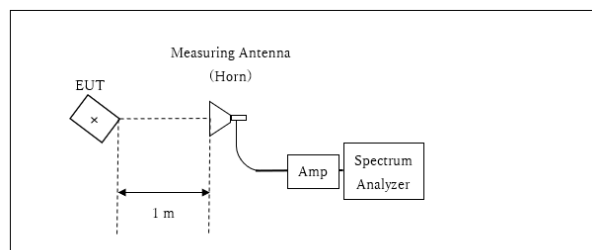
* Test Distance: $(3 + \text{Test Volume} / 2) - r = 4.0 \text{ m}$

Test Volume : 2.0 m

(Test Volume has been calibrated based on CISPR 16-1-4.)

r = 0.0 m

10 GHz - 26.5 GHz



x : Center of turn table

Distance Factor: $20 \times \log (1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$

*Test Distance: 1 m

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30 MHz - 26.5 GHz

Test data : APPENDIX

Test result : Pass

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SECTION 6: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
Maximum Peak Output Power	-	-	-	Auto	Peak Average *1)	-	Power Meter (Sensor: 50MHz BW)
*1) Reference data							

The test results and limit are rounded off to two decimals place, so some differences might be observed.
The equipment and cables were not used for factor 0 dB of the data sheets.

Test data : APPENDIX

Test result : Pass

APPENDIX 1: Test data

Maximum Peak Output Power

Report No.	13074034H
Test place	Ise EMC Lab. No.4 Semi Anechoic chamber
Date	October 19, 2019
Temperature / Humidity	23 deg. C / 68 % RH
Engineer	Tomohisa Nakagawa
Mode	Tx, Hopping Off

Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
DH5	2402.0	-8.70	0.23	9.49	1.02	1.26	20.96	125	19.94
DH5	2441.0	-6.35	0.23	9.49	3.37	2.17	20.96	125	17.59
DH5	2480.0	-4.31	0.23	9.49	5.41	3.48	20.96	125	15.55
2DH5	2402.0	-11.75	0.23	9.49	-2.03	0.63	20.96	125	22.99
2DH5	2441.0	-9.33	0.23	9.49	0.39	1.09	20.96	125	20.57
2DH5	2480.0	-6.82	0.23	9.49	2.90	1.95	20.96	125	18.06
3DH5	2402.0	-11.34	0.23	9.49	-1.62	0.69	20.96	125	22.58
3DH5	2441.0	-8.93	0.23	9.49	0.79	1.20	20.96	125	20.17
3DH5	2480.0	-6.47	0.23	9.49	3.25	2.11	20.96	125	17.71

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

*The equipment and cables were not used for factor 0 dB of the data sheets.

Average Output Power (Reference data for RF Exposure)

Report No.	13074034H
Test place	Ise EMC Lab. No.4 Semi Anechoic chamber
Date	October 19, 2019
Temperature / Humidity	23 deg. C / 68 % RH
Engineer	Tomohisa Nakagawa
Mode	Tx, Hopping Off

Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result (Time average)		Duty factor [dB]	Result (Burst power average)	
					[dBm]	[mW]		[dBm]	[mW]
DH5	2402.0	-10.49	0.23	9.49	-0.77	0.84	1.07	0.30	1.07
DH5	2441.0	-8.09	0.23	9.49	1.63	1.46	1.07	2.70	1.86
DH5	2480.0	-5.92	0.23	9.49	3.80	2.40	1.07	4.87	3.07
2DH5	2402.0	-16.23	0.23	9.49	-6.51	0.22	1.07	-5.44	0.29
2DH5	2441.0	-13.75	0.23	9.49	-4.03	0.40	1.07	-2.96	0.51
2DH5	2480.0	-11.34	0.23	9.49	-1.62	0.69	1.07	-0.55	0.88
3DH5	2402.0	-16.23	0.23	9.49	-6.51	0.22	1.07	-5.44	0.29
3DH5	2441.0	-13.87	0.23	9.49	-4.15	0.38	1.07	-3.08	0.49
3DH5	2480.0	-11.30	0.23	9.49	-1.58	0.70	1.07	-0.51	0.89

Sample Calculation:

Result (Time average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

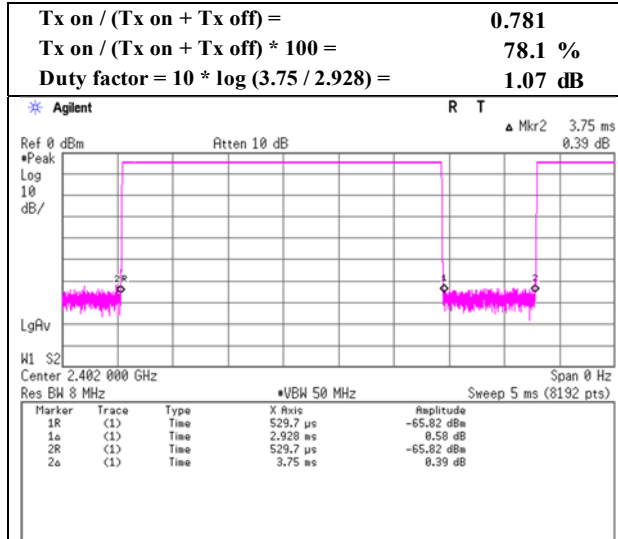
Result (Burst power average) = Time average + Duty factor

*The equipment and cables were not used for factor 0 dB of the data sheets.

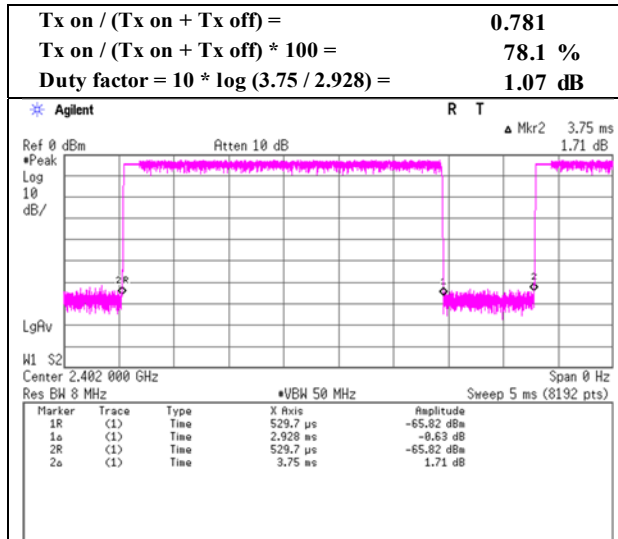
Burst Rate Confirmation

Report No.	13074034H
Test place	Ise EMC Lab. No.4 Semi Anechoic chamber
Date	October 19, 2019
Temperature / Humidity	23 deg. C / 68 % RH
Engineer	Tomohisa Nakagawa
Mode	Tx, Hopping Off

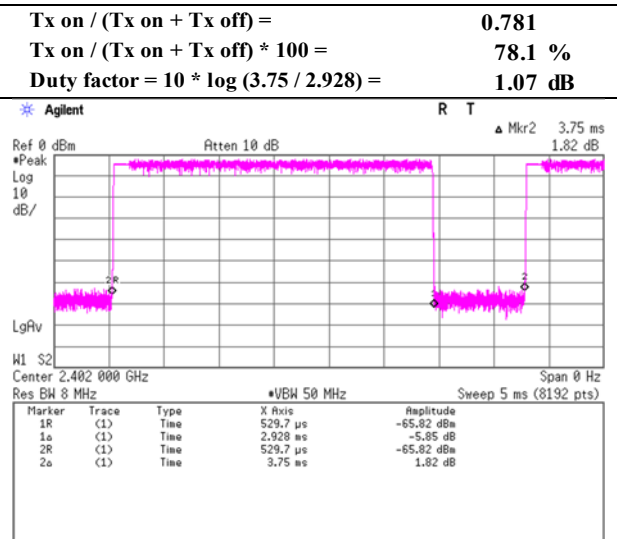
DH5



2DH5

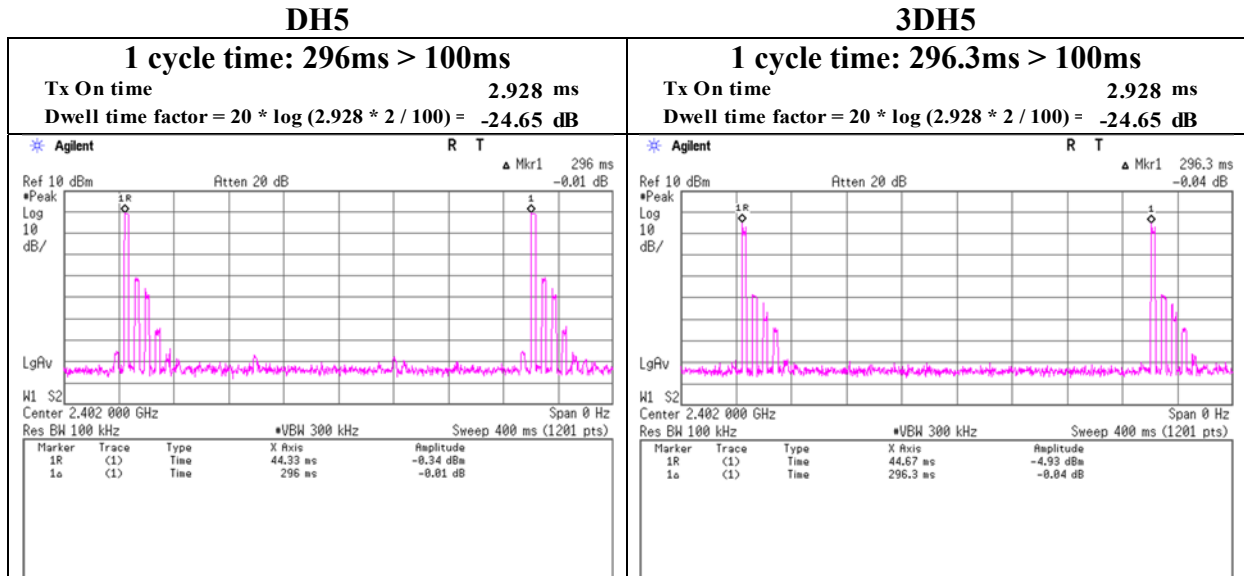


3DH5



Duty cycle correction factor

Report No.	13074034H
Test place	Ise EMC Lab. No.4 Semi Anechoic chamber
Date	October 19, 2019
Temperature / Humidity	23 deg. C / 68 % RH
Engineer	Tomohisa Nakagawa
Mode	Tx, Hopping Off



A hopping channel might be occupied 2 times within 100 ms on minimum hopping mode (AFH). Therefore Tx On time was multiplied by 2. As for Tx On time, refer to "Burst Rate Confirmation".

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Radiated Spurious Emission

Report No. 13074034H
Test place Ise EMC Lab. No.4 Semi Anechoic chamber
Date October 19, 2019 October 20, 2019
Temperature / Humidity 23 deg. C / 68 % RH 22 deg. C / 65 % RH
Engineer Tomohisa Nakagawa Tomohisa Nakagawa
Mode Tx, Hopping Off, DH5 2402MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	57.073	QP	22.2	8.7	7.9	32.2	-	6.7	40.0	33.4	
Hori.	70.665	QP	31.1	6.3	8.1	32.1	-	13.4	40.0	26.6	
Hori.	130.640	QP	25.2	13.8	8.7	32.1	-	15.7	43.5	27.8	
Hori.	399.400	QP	23.9	15.7	10.8	32.0	-	18.5	46.0	27.5	
Hori.	450.200	QP	34.4	16.7	11.1	32.0	-	30.2	46.0	15.8	
Hori.	498.650	QP	26.6	17.7	11.4	32.0	-	23.7	46.0	22.3	
Hori.	2390.000	PK	41.4	27.9	5.9	31.9	-	43.4	73.9	30.6	
Hori.	4804.000	PK	51.5	31.7	8.1	31.3	-	60.0	73.9	13.9	
Hori.	7206.000	PK	43.7	36.2	8.7	32.4	-	56.2	73.9	17.7	Floor noise
Hori.	9608.000	PK	45.0	38.0	9.7	32.8	-	59.9	73.9	14.0	Floor noise
Hori.	2390.000	AV	33.5	27.9	5.9	31.9	1.1	36.5	53.9	17.4	*1)
Hori.	7206.000	AV	34.5	36.2	8.7	32.4	-	47.0	53.9	6.9	Floor noise
Hori.	9608.000	AV	36.3	38.0	9.7	32.8	-	51.2	53.9	2.7	Floor noise
Vert.	56.995	QP	33.3	8.7	7.9	32.2	-	17.8	40.0	22.2	
Vert.	71.330	QP	38.3	6.3	8.1	32.1	-	20.5	40.0	19.5	
Vert.	130.683	QP	31.7	13.8	8.7	32.1	-	22.2	43.5	21.3	
Vert.	399.990	QP	30.4	15.8	10.8	32.0	-	25.0	46.0	21.0	
Vert.	451.600	QP	35.3	16.7	11.1	32.0	-	31.2	46.0	14.8	
Vert.	600.563	QP	29.6	19.3	11.9	32.1	-	28.8	46.0	17.2	
Vert.	2390.000	PK	41.4	27.9	5.9	31.9	-	43.3	73.9	30.6	
Vert.	4804.000	PK	50.4	31.7	8.1	31.3	-	58.8	73.9	15.1	
Vert.	7206.000	PK	43.2	36.2	8.7	32.4	-	55.7	73.9	18.2	Floor noise
Vert.	9608.000	PK	45.2	38.0	9.7	32.8	-	60.1	73.9	13.8	Floor noise
Vert.	2390.000	AV	31.0	27.9	5.9	31.9	1.1	33.9	53.9	20.0	*1)
Vert.	7206.000	AV	34.3	36.2	8.7	32.4	-	46.8	53.9	7.1	Floor noise
Vert.	9608.000	AV	35.7	38.0	9.7	32.8	-	50.6	53.9	3.3	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.0 m / 3.0 m) = 2.5 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

***These results have sufficient margin without taking account Duty cycle correction factor.**

20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2402.000	PK	81.2	27.9	5.9	31.9	83.1	-	-	Carrier
Hori.	2400.000	PK	35.2	27.9	5.9	31.9	37.2	63.1	26.0	
Vert.	2402.000	PK	80.1	27.9	5.9	31.9	82.0	-	-	Carrier
Vert.	2400.000	PK	34.6	27.9	5.9	31.9	36.5	62.0	25.5	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Dwell time factor relaxation

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Dwell Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	4804.000	AV	47.9	31.7	8.1	31.3	-24.7	31.7	53.9	22.2	*
Vert.	4804.000	AV	46.6	31.7	8.1	31.3	-24.7	30.5	53.9	23.4	*

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz))

- Gain(Amplifier) + Dwell time factor (Refer to dwell time data sheet)

*Above noise was synchronized with carrier frequency.

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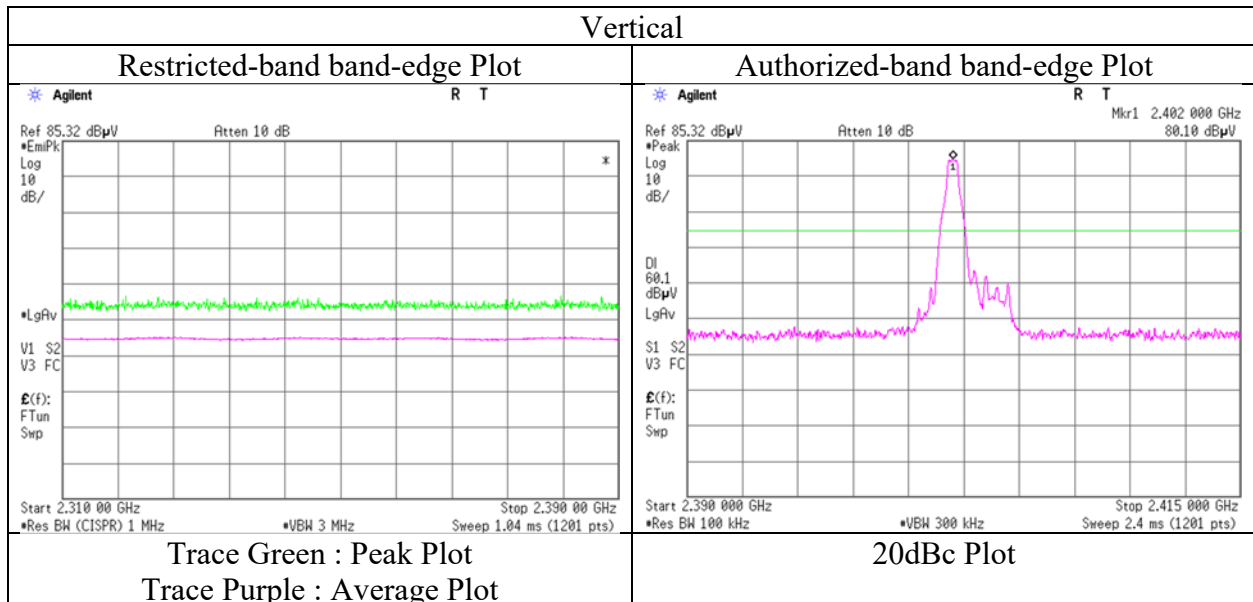
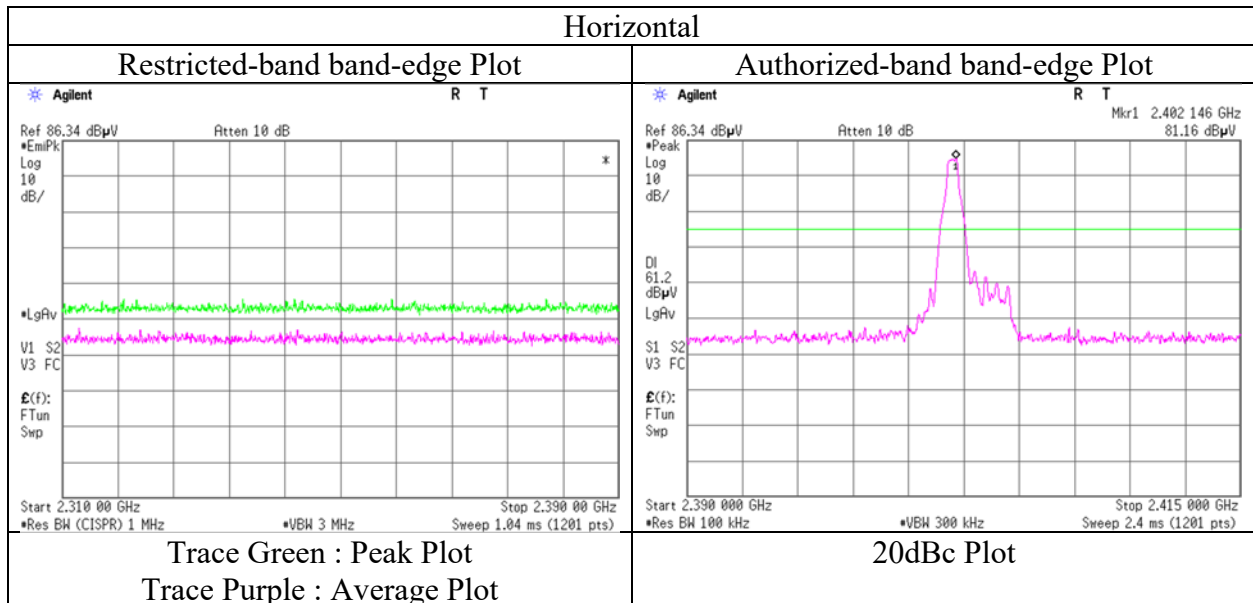
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Radiated Spurious Emission (Reference Plot for band-edge)

Report No.	13074034H
Test place	Ise EMC Lab. No.4 Semi Anechoic chamber
Date	October 19, 2019
Temperature / Humidity	23 deg. C / 68 % RH
Engineer	Tomohisa Nakagawa
Mode	Tx, Hopping Off, DH5 2402MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

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Radiated Spurious Emission

Report No. 13074034H
Test place Ise EMC Lab. No.4 Semi Anechoic chamber
Date October 19, 2019 October 20, 2019
Temperature / Humidity 23 deg. C / 68 % RH 22 deg. C / 65 % RH
Engineer Tomohisa Nakagawa Tomohisa Nakagawa
Mode Tx, Hopping Off, DH5 2441MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	57.753	QP	23.1	8.5	7.9	32.2	-	7.3	40.0	32.7	
Hori.	70.340	QP	29.5	6.3	8.1	32.1	-	11.8	40.0	28.2	
Hori.	128.970	QP	25.0	13.8	8.7	32.1	-	15.5	43.5	28.1	
Hori.	399.052	QP	29.6	15.7	10.8	32.0	-	24.1	46.0	21.9	
Hori.	451.764	QP	33.2	16.7	11.1	32.0	-	29.1	46.0	16.9	
Hori.	499.800	QP	29.8	17.7	11.4	32.0	-	26.9	46.0	19.1	
Hori.	4882.000	PK	51.4	31.6	8.1	31.2	-	59.9	73.9	14.0	
Hori.	7323.000	PK	42.6	36.5	8.7	32.5	-	55.3	73.9	18.6	Floor noise
Hori.	9764.000	PK	43.8	38.3	9.7	32.9	-	59.0	73.9	14.9	Floor noise
Hori.	7323.000	AV	34.0	36.5	8.7	32.5	-	46.8	53.9	7.1	Floor noise
Hori.	9764.000	AV	35.5	38.3	9.7	32.9	-	50.6	53.9	3.3	Floor noise
Vert.	57.970	QP	31.3	8.4	7.9	32.2	-	15.4	40.0	24.6	
Vert.	70.205	QP	37.7	6.3	8.1	32.1	-	20.0	40.0	20.0	
Vert.	129.620	QP	31.7	13.8	8.7	32.1	-	22.1	43.5	21.4	
Vert.	399.592	QP	28.1	15.8	10.8	32.0	-	22.7	46.0	23.3	
Vert.	451.800	QP	34.8	16.7	11.1	32.0	-	30.7	46.0	15.3	
Vert.	600.563	QP	29.7	19.3	11.9	32.1	-	28.9	46.0	17.1	
Vert.	4882.000	PK	49.5	31.6	8.1	31.2	-	58.0	73.9	15.9	
Vert.	7323.000	PK	43.0	36.5	8.7	32.5	-	55.7	73.9	18.2	Floor noise
Vert.	9764.000	PK	43.6	38.3	9.7	32.9	-	58.7	73.9	15.2	Floor noise
Vert.	7323.000	AV	33.5	36.5	8.7	32.5	-	46.3	53.9	7.6	Floor noise
Vert.	9764.000	AV	35.6	38.3	9.7	32.9	-	50.7	53.9	3.2	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.0 m / 3.0 m) = 2.5 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

***These results have sufficient margin without taking account Duty cycle correction factor.**

Dwell time factor relaxation

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Dwell Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	4882.000	AV	47.0	31.6	8.1	31.2	-24.7	30.8	53.9	23.1	*
Vert.	4882.000	AV	45.2	31.6	8.1	31.2	-24.7	29.0	53.9	24.9	*

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz))

- Gain(Amplifier) + Dwell time factor (Refer to dwell time data sheet)

*Above noise was synchronized with carrier frequency.

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Radiated Spurious Emission

Report No. 13074034H
Test place Ise EMC Lab. No.4 Semi Anechoic chamber
Date October 19, 2019 October 20, 2019
Temperature / Humidity 23 deg. C / 68 % RH 22 deg. C / 65 % RH
Engineer Tomohisa Nakagawa Tomohisa Nakagawa
Mode Tx, Hopping Off, DH5 2480MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	57.668	QP	23.1	8.5	7.9	32.2	-	7.3	40.0	32.7	
Hori.	67.868	QP	30.0	6.4	8.0	32.1	-	12.3	40.0	27.7	
Hori.	133.403	QP	24.8	14.0	8.8	32.1	-	15.5	43.5	28.0	
Hori.	399.600	QP	23.9	15.8	10.8	32.0	-	18.5	46.0	27.5	
Hori.	450.349	QP	34.5	16.7	11.1	32.0	-	30.3	46.0	15.7	
Hori.	498.000	QP	27.9	17.7	11.4	32.0	-	25.0	46.0	21.1	
Hori.	2483.500	PK	44.9	27.7	6.0	31.8	-	46.8	73.9	27.1	
Hori.	4960.000	PK	50.7	31.6	8.1	31.2	-	59.2	73.9	14.7	
Hori.	7440.000	PK	42.0	36.6	8.8	32.5	-	54.8	73.9	19.1	Floor noise
Hori.	9920.000	PK	40.7	38.5	9.8	33.0	-	56.0	73.9	17.9	Floor noise
Hori.	2483.500	AV	39.2	27.7	6.0	31.8	1.1	42.1	53.9	11.8	*1)
Hori.	7440.000	AV	33.4	36.6	8.8	32.5	-	46.2	53.9	7.7	Floor noise
Hori.	9920.000	AV	35.0	38.5	9.8	33.0	-	50.3	53.9	3.6	Floor noise
Vert.	55.288	QP	33.2	9.3	7.9	32.2	-	18.2	40.0	21.8	
Vert.	70.928	QP	38.1	6.3	8.1	32.1	-	20.3	40.0	19.7	
Vert.	130.938	QP	32.0	13.8	8.8	32.1	-	22.5	43.5	21.0	
Vert.	399.200	QP	33.9	15.7	10.8	32.0	-	28.5	46.0	17.6	
Vert.	451.800	QP	34.7	16.7	11.1	32.0	-	30.6	46.0	15.4	
Vert.	600.200	QP	29.3	19.3	11.9	32.1	-	28.5	46.0	17.5	
Vert.	2483.500	PK	46.0	27.7	6.0	31.8	-	47.9	73.9	26.0	
Vert.	4960.000	PK	49.1	31.6	8.1	31.2	-	57.6	73.9	16.3	
Vert.	7440.000	PK	42.5	36.6	8.8	32.5	-	55.3	73.9	18.6	Floor noise
Vert.	9920.000	PK	43.3	38.5	9.8	33.0	-	58.7	73.9	15.3	Floor noise
Vert.	2483.500	AV	41.2	27.7	6.0	31.8	1.1	44.1	53.9	9.8	*1)
Vert.	7440.000	AV	33.4	36.6	8.8	32.5	-	46.3	53.9	7.7	Floor noise
Vert.	9920.000	AV	35.0	38.5	9.8	33.0	-	50.3	53.9	3.6	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(4.0\text{ m} / 3.0\text{ m}) = 2.5\text{ dB}$

10 GHz - 26.5 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

*1) Not Out of Band emission(Leakage Power)

***These results have sufficient margin without taking account Duty cycle correction factor.**

Dwell time factor relaxation

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Dwell Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	4960.000	AV	47.2	31.6	8.1	31.2	-24.7	31.1	53.9	22.8	*
Vert.	4960.000	AV	44.7	31.6	8.1	31.2	-24.7	28.5	53.9	25.4	*

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz))

- Gain(Amplifier) + Dwell time factor (Refer to dwell time data sheet)

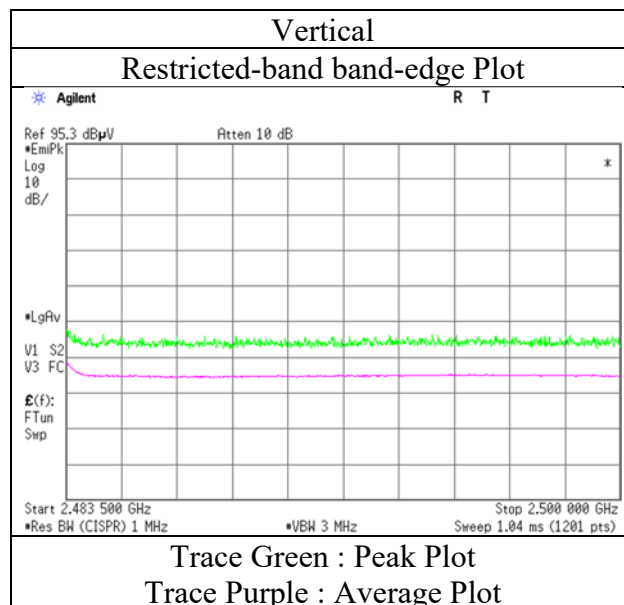
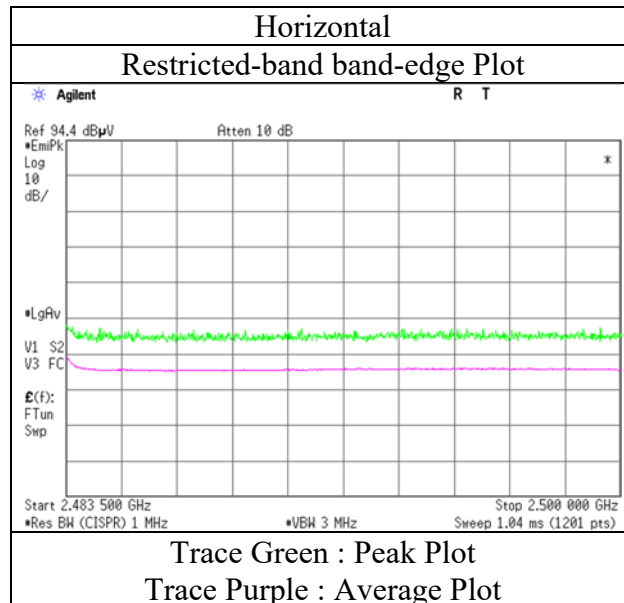
*Above noise was synchronized with carrier frequency.

Distance factor: 1 GHz - 10 GHz $20\log(4.5\text{ m} / 3.0\text{ m}) = 3.53\text{ dB}$

10 GHz - 26.5 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

Radiated Spurious Emission (Reference Plot for band-edge)

Report No.	13074034H
Test place	Ise EMC Lab. No.4 Semi Anechoic chamber
Date	October 19, 2019
Temperature / Humidity	23 deg. C / 68 % RH
Engineer	Tomohisa Nakagawa
Mode	Tx, Hopping Off, DH5 2480MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Report No. 13074034H
Test place Ise EMC Lab. No.4 Semi Anechoic chamber
Date October 19, 2019 October 20, 2019
Temperature / Humidity 23 deg. C / 68 % RH 22 deg. C / 65 % RH
Engineer Tomohisa Nakagawa Tomohisa Nakagawa
Mode Tx, Hopping Off, 3DH5 2402MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	56.010	QP	23.1	9.0	7.9	32.2	-	7.9	40.0	32.2	
Hori.	70.679	QP	30.2	6.3	8.1	32.1	-	12.5	40.0	27.5	
Hori.	135.188	QP	23.9	14.2	8.8	32.1	-	14.8	43.5	28.7	
Hori.	407.110	QP	27.0	15.9	10.8	32.0	-	21.8	46.0	24.2	
Hori.	450.670	QP	33.8	16.7	11.1	32.0	-	29.6	46.0	16.4	
Hori.	498.000	QP	28.6	17.7	11.4	32.0	-	25.7	46.0	20.4	
Hori.	2390.000	PK	41.7	27.9	5.9	31.9	-	43.6	73.9	30.3	
Hori.	4804.000	PK	48.7	31.7	7.3	31.3	-	56.4	73.9	17.5	
Hori.	7206.000	PK	42.9	36.2	8.7	32.4	-	55.4	73.9	18.5	Floor noise
Hori.	9608.000	PK	43.4	38.0	9.7	32.8	-	58.3	73.9	15.6	Floor noise
Hori.	2390.000	AV	33.2	27.9	5.9	31.9	1.1	36.1	53.9	17.8	*1)
Hori.	7206.000	AV	35.0	36.2	8.7	32.4	-	47.6	53.9	6.4	Floor noise
Hori.	9608.000	AV	35.8	38.0	9.7	32.8	-	50.7	53.9	3.2	Floor noise
Vert.	56.277	QP	33.3	9.0	7.9	32.2	-	18.0	40.0	22.0	
Vert.	71.495	QP	38.0	6.3	8.1	32.1	-	20.2	40.0	19.8	
Vert.	129.068	QP	31.2	13.8	8.7	32.1	-	21.7	43.5	21.9	
Vert.	400.721	QP	33.0	15.8	10.8	32.0	-	27.6	46.0	18.4	
Vert.	451.600	QP	34.6	16.7	11.1	32.0	-	30.5	46.0	15.5	
Vert.	600.000	QP	29.7	19.3	11.9	32.1	-	28.9	46.0	17.1	
Vert.	2390.000	PK	41.6	27.9	5.9	31.9	-	43.5	73.9	30.4	
Vert.	4804.000	PK	48.5	31.7	7.3	31.3	-	56.2	73.9	17.7	
Vert.	7206.000	PK	43.6	36.2	8.7	32.4	-	56.1	73.9	17.8	Floor noise
Vert.	9608.000	PK	42.9	38.0	9.7	32.8	-	57.8	73.9	16.1	Floor noise
Vert.	2390.000	AV	30.7	27.9	5.9	31.9	1.1	33.6	53.9	20.3	*1)
Vert.	7206.000	AV	35.1	36.2	8.7	32.4	-	47.6	53.9	6.3	Floor noise
Vert.	9608.000	AV	35.9	38.0	9.7	32.8	-	50.8	53.9	3.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.0 m / 3.0 m) = 2.5 dB

10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

***These results have sufficient margin without taking account Duty cycle correction factor.**

20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2402.000	PK	75.7	27.9	5.9	31.9	77.7	-	-	Carrier
Hori.	2400.000	PK	33.4	27.9	5.9	31.9	35.3	57.7	22.4	
Vert.	2402.000	PK	76.0	27.9	5.9	31.9	77.9	-	-	Carrier
Vert.	2400.000	PK	34.0	27.9	5.9	31.9	35.9	57.9	22.0	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Dwell time factor relaxation

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Dwell Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	4804.000	AV	43.7	31.7	7.3	31.3	-24.7	26.7	53.9	27.2	*
Vert.	4804.000	AV	43.8	31.7	7.3	31.3	-24.7	26.9	53.9	27.0	*

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz))

- Gain(Amplifier) + Dwell time factor (Refer to dwell time data sheet)

*Above noise was synchronized with carrier frequency.

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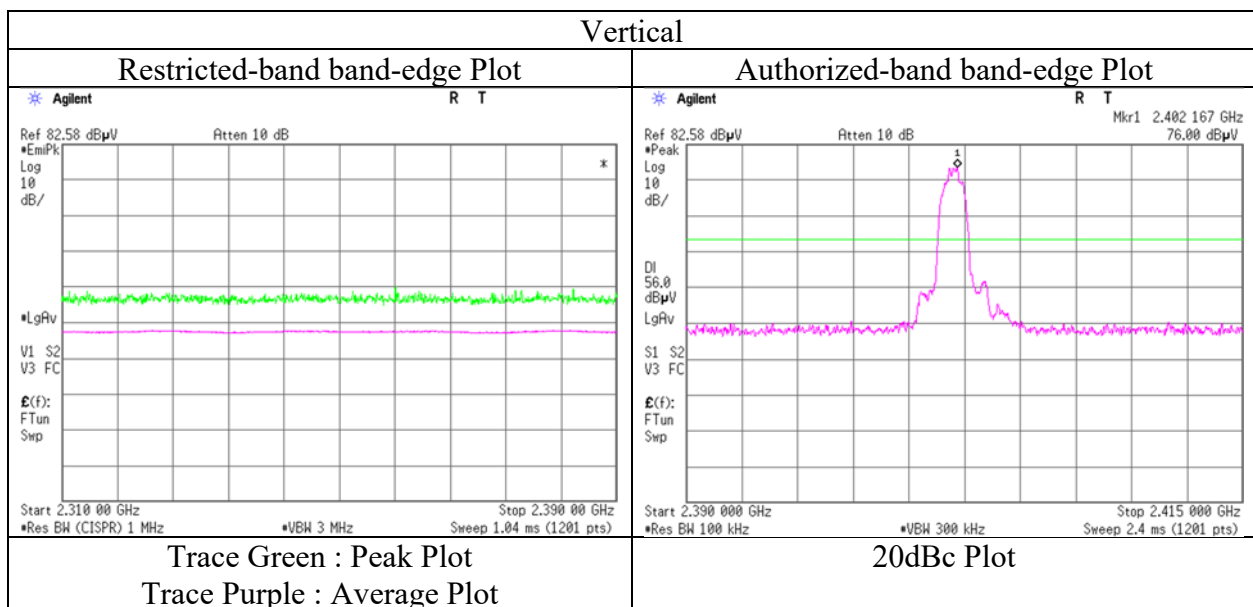
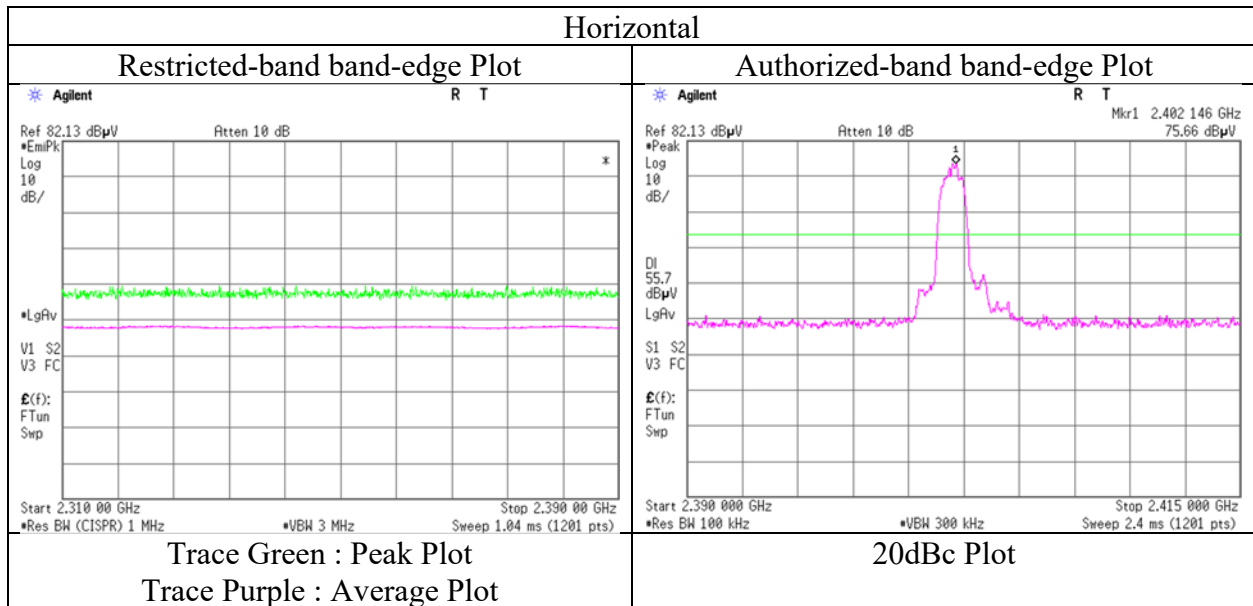
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Radiated Spurious Emission (Reference Plot for band-edge)

Report No.	13074034H
Test place	Ise EMC Lab. No.4 Semi Anechoic chamber
Date	October 19, 2019
Temperature / Humidity	23 deg. C / 68 % RH
Engineer	Tomohisa Nakagawa
Mode	Tx, Hopping Off, 3DH5 2402MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Report No. 13074034H
Test place Ise EMC Lab. No.4 Semi Anechoic chamber
Date October 19, 2019 October 20, 2019
Temperature / Humidity 23 deg. C / 68 % RH 22 deg. C / 65 % RH
Engineer Tomohisa Nakagawa Tomohisa Nakagawa
Mode Tx, Hopping Off, 3DH5 2441MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	56.180	QP	23.2	9.0	7.9	32.2	-	7.9	40.0	32.1	
Hori.	70.673	QP	30.5	6.3	8.1	32.1	-	12.8	40.0	27.2	
Hori.	129.478	QP	24.8	13.8	8.7	32.1	-	15.2	43.5	28.3	
Hori.	399.200	QP	23.1	15.7	10.8	32.0	-	17.7	46.0	28.4	
Hori.	450.336	QP	34.5	16.7	11.1	32.0	-	30.3	46.0	15.7	
Hori.	498.000	QP	28.9	17.7	11.4	32.0	-	26.0	46.0	20.1	
Hori.	4882.000	PK	50.9	31.6	8.1	31.2	-	59.4	73.9	14.5	
Hori.	7323.000	PK	41.3	36.5	8.7	32.5	-	54.0	73.9	19.9	Floor noise
Hori.	9764.000	PK	44.0	38.3	9.7	32.9	-	59.1	73.9	14.8	Floor noise
Hori.	7323.000	AV	35.1	36.5	8.7	32.5	-	47.8	53.9	6.1	Floor noise
Hori.	9764.000	AV	35.4	38.3	9.7	32.9	-	50.5	53.9	3.4	Floor noise
Vert.	56.605	QP	32.6	8.9	7.9	32.2	-	17.2	40.0	22.8	
Vert.	70.715	QP	38.1	6.3	8.1	32.1	-	20.4	40.0	19.7	
Vert.	130.250	QP	31.0	13.8	8.7	32.1	-	21.5	43.5	22.1	
Vert.	399.000	QP	30.1	15.7	10.8	32.0	-	24.6	46.0	21.4	
Vert.	451.600	QP	35.0	16.7	11.1	32.0	-	30.9	46.0	15.1	
Vert.	600.120	QP	29.0	19.3	11.9	32.1	-	28.2	46.0	17.8	
Vert.	4882.000	PK	49.8	31.6	8.1	31.2	-	58.2	73.9	15.7	
Vert.	7323.000	PK	41.7	36.5	8.7	32.5	-	54.5	73.9	19.4	Floor noise
Vert.	9764.000	PK	42.5	38.3	9.7	32.9	-	57.6	73.9	16.3	Floor noise
Vert.	7323.000	AV	35.8	36.5	8.7	32.5	-	48.5	53.9	5.4	Floor noise
Vert.	9764.000	AV	35.4	38.3	9.7	32.9	-	50.5	53.9	3.4	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(4.0\text{ m} / 3.0\text{ m}) = 2.5\text{ dB}$
10 GHz - 26.5 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

***These results have sufficient margin without taking account Duty cycle correction factor.**

Dwell time factor relaxation

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Dwell Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	4882.000	AV	44.8	31.6	8.1	31.2	-24.7	28.6	53.9	25.3	*
Vert.	4882.000	AV	43.0	31.6	8.1	31.2	-24.7	26.8	53.9	27.1	*

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz))

- Gain(Amplifier) + Dwell time factor (Refer to dwell time data sheet)

*Above noise was synchronized with carrier frequency.

Radiated Spurious Emission

Report No. 13074034H
Test place Ise EMC Lab. No.4 Semi Anechoic chamber
Date October 19, 2019
Temperature / Humidity 23 deg. C / 68 % RH
Engineer Tomohisa Nakagawa
Mode Tx, Hopping Off, 3DH5 2480MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	55.713	QP	23.0	9.1	7.9	32.2	-	7.8	40.0	32.2	
Hori.	72.033	QP	30.5	6.3	8.1	32.1	-	12.7	40.0	27.3	
Hori.	151.083	QP	26.8	15.1	9.0	32.1	-	18.8	43.5	24.7	
Hori.	399.400	QP	23.1	15.7	10.8	32.0	-	17.7	46.0	28.3	
Hori.	451.400	QP	32.5	16.7	11.1	32.0	-	28.4	46.0	17.6	
Hori.	498.000	QP	29.1	17.7	11.4	32.0	-	26.2	46.0	19.9	
Hori.	2483.500	PK	41.3	27.7	6.0	31.8	-	43.1	73.9	30.8	
Hori.	4960.000	PK	50.1	31.6	8.1	31.2	-	58.6	73.9	15.3	
Hori.	7440.000	PK	42.1	36.6	8.8	32.5	-	54.9	73.9	19.0	Floor noise
Hori.	9920.000	PK	42.9	38.5	9.8	33.0	-	58.2	73.9	15.7	Floor noise
Hori.	2483.500	AV	31.3	27.7	6.0	31.8	1.1	34.3	53.9	19.6	*1)
Hori.	7440.000	AV	33.8	36.6	8.8	32.5	-	46.6	53.9	7.3	Floor noise
Hori.	9920.000	AV	34.7	38.5	9.8	33.0	-	50.1	53.9	3.9	Floor noise
Vert.	54.395	QP	33.0	9.6	7.9	32.2	-	18.3	40.0	21.7	
Vert.	70.843	QP	38.3	6.3	8.1	32.1	-	20.6	40.0	19.5	
Vert.	130.215	QP	31.9	13.8	8.7	32.1	-	22.4	43.5	21.2	
Vert.	399.600	QP	30.2	15.8	10.8	32.0	-	24.8	46.0	21.2	
Vert.	451.200	QP	33.6	16.7	11.1	32.0	-	29.5	46.0	16.6	
Vert.	601.274	QP	31.9	19.4	12.0	32.1	-	31.1	46.0	14.9	
Vert.	2483.500	PK	42.9	27.7	6.0	31.8	-	44.7	73.9	29.2	
Vert.	4960.000	PK	49.5	31.6	8.1	31.2	-	58.1	73.9	15.9	
Vert.	7440.000	PK	41.9	36.6	8.8	32.5	-	54.7	73.9	19.2	Floor noise
Vert.	9920.000	PK	42.4	38.5	9.8	33.0	-	57.7	73.9	16.2	Floor noise
Vert.	2483.500	AV	34.2	27.7	6.0	31.8	1.1	37.1	53.9	16.8	*1)
Vert.	7440.000	AV	33.7	36.6	8.8	32.5	-	46.5	53.9	7.4	Floor noise
Vert.	9920.000	AV	35.2	38.5	9.8	33.0	-	50.5	53.9	3.4	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.0 m / 3.0 m) = 2.5 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

***These results have sufficient margin without taking account Duty cycle correction factor.**

Dwell time factor relaxation

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Dwell Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	4960.000	AV	43.3	31.6	8.1	31.2	-24.7	27.2	53.9	26.7	*
Vert.	4960.000	AV	41.3	31.6	8.1	31.2	-24.7	25.2	53.9	28.7	*

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz))

- Gain(Amplifier) + Dwell time factor (Refer to dwell time data sheet)

*Above noise was synchronized with carrier frequency.

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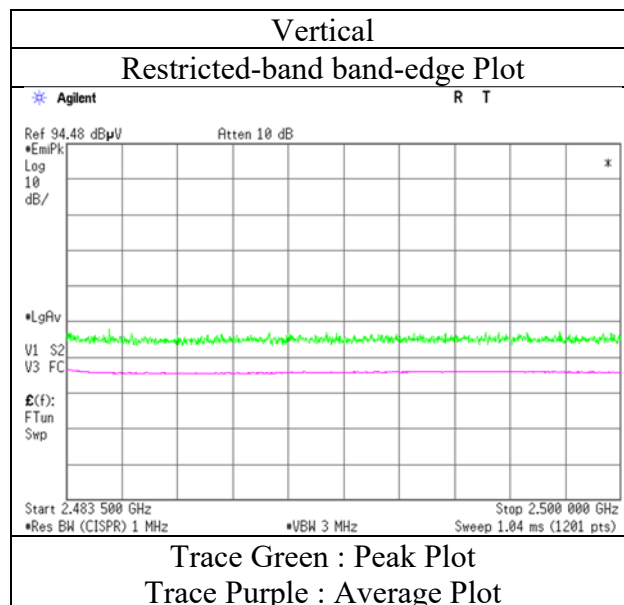
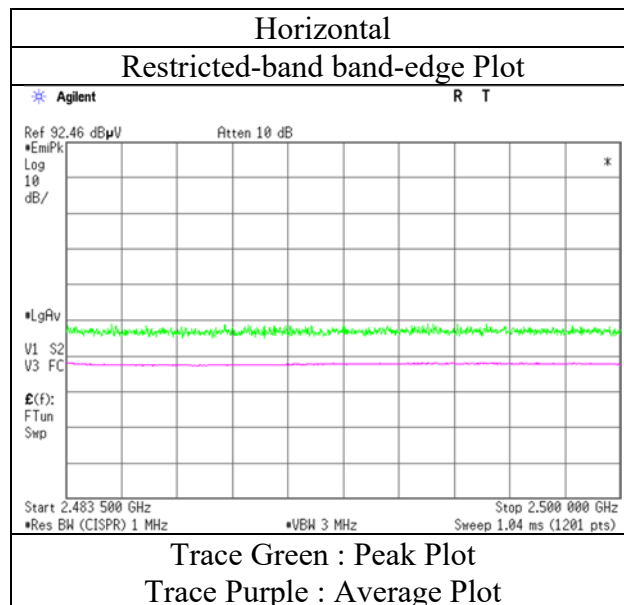
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Radiated Spurious Emission (Reference Plot for band-edge)

Report No.	13074034H
Test place	Ise EMC Lab. No.4 Semi Anechoic chamber
Date	October 19, 2019
Temperature / Humidity	23 deg. C / 68 % RH
Engineer	Tomohisa Nakagawa
Mode	Tx, Hopping Off, 3DH5 2480MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

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Ise EMC Lab.

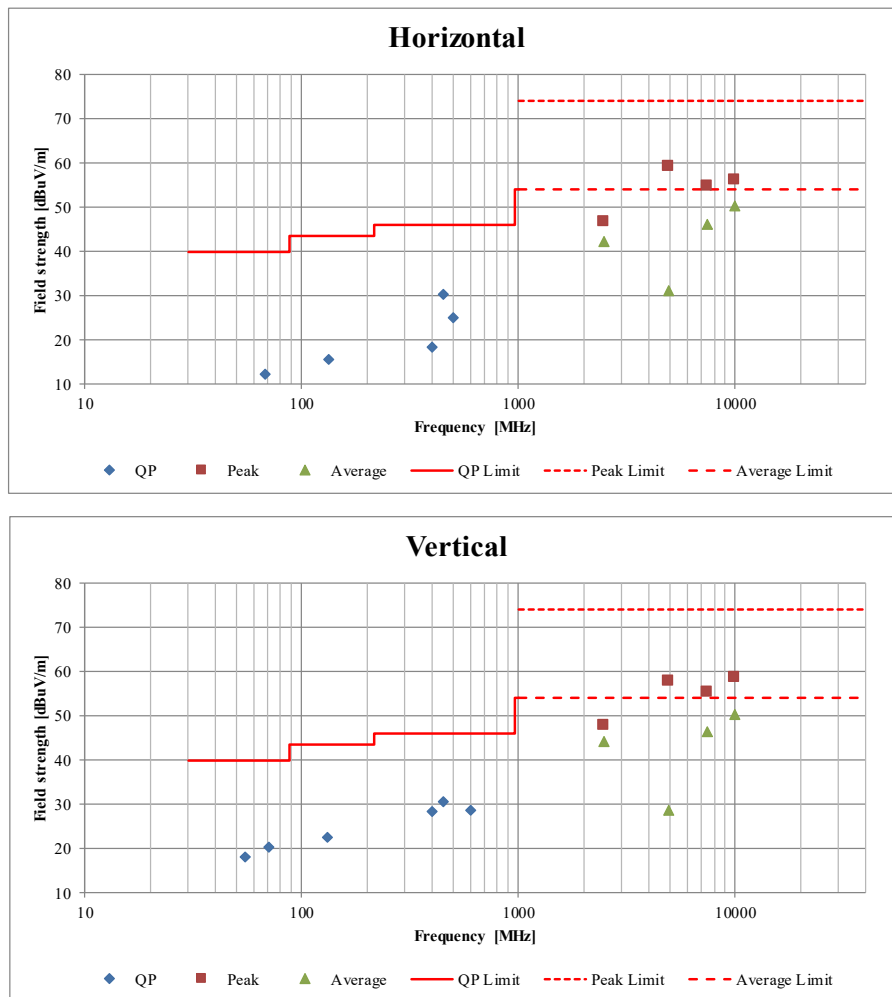
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Radiated Spurious Emission **(Plot data, Worst case)**

Report No. 13074034H
Test place Ise EMC Lab. No.4 Semi Anechoic chamber
Date October 19, 2019
Temperature / Humidity 23 deg. C / 68 % RH
Engineer Tomohisa Nakagawa
Mode Tx, Hopping Off, DH5 2480MHz



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

APPENDIX 2: Test instruments

Test Instruments

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	148898	Attenuator	EMC Instruments Corporation	8491A	MY52462282	10/03/2018	10/31/2019	12
RE	142227	Measure	KOMELON	KMC-36	-	-	-	-
RE	141397	Coaxial Cable	UL Japan	-	-	06/18/2019	06/30/2020	12
RE/AT	141545	DIGITAL HiTESTER	HIOKI	3805	51201148	01/29/2019	01/31/2020	12
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	08/02/2019	08/31/2020	12
RE	141152	EMI measurement program	TSJ	TEPTO-DV	-	-	-	-
RE	141267	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	9111B-192	08/24/2019	08/31/2020	12
RE	141583	Pre Amplifier	SONOMA INSTRUMENT	310	260833	02/08/2019	02/29/2020	12
RE	142011	AC4 Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	06/28/2018	06/30/2020	24
RE/AT	141562	Thermo-Hygrometer	CUSTOM	CTH-201	0010	01/11/2019	01/31/2020	12
RE	142017	AC4 Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/04/2019	04/30/2021	24
RE	141508	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	09/26/2019	09/30/2020	12
RE	141506	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170307	10/08/2019	10/31/2020	12
RE	141581	MicroWave System Amplifier	AGILENT	83017A	650	10/16/2019	10/31/2020	12
RE	141412	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1405S146(5m)	06/17/2019	06/30/2020	12
AT	141223	Attenuator	Weinschel Associates	WA56-10	56100306	05/17/2019	05/31/2020	12
AT	141805	Power Meter	ANRITSU	ML2495A	6K00003338	10/03/2019	10/31/2020	12
AT	141840	Power sensor	ANRITSU	MA2411B	11737	10/03/2019	10/31/2020	12
RE	141425	Biconical Antenna	Schwarzbeck	VHA9103 +BBA9106	1302	08/24/2019	08/31/2020	12

*Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item: RE: Radiated Emission test
AT: Antenna Terminal Conducted test

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APPENDIX 3: Photographs of test setup

Radiated Spurious Emission



Photo 1

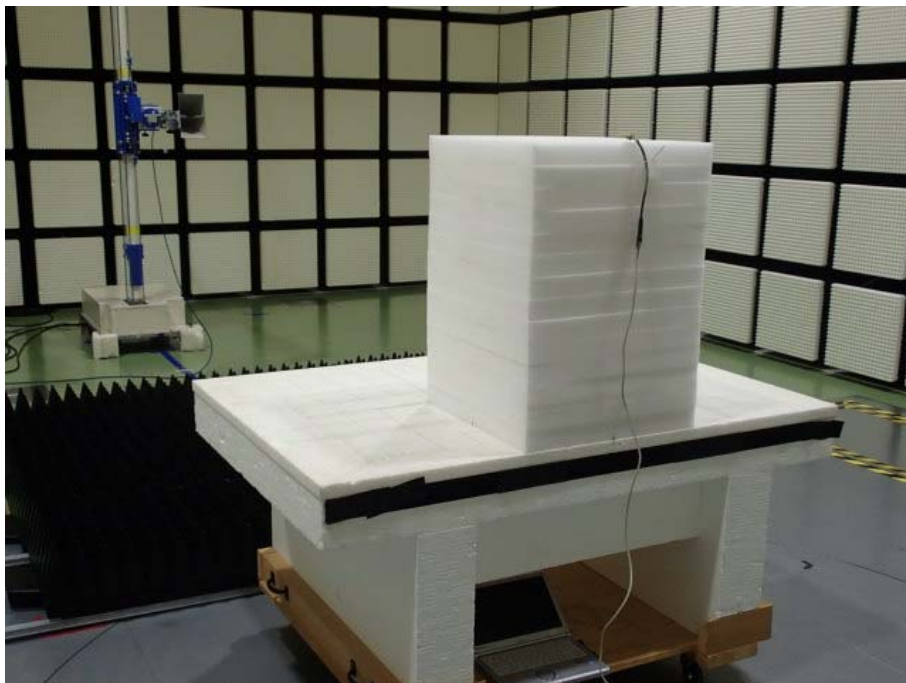


Photo 2

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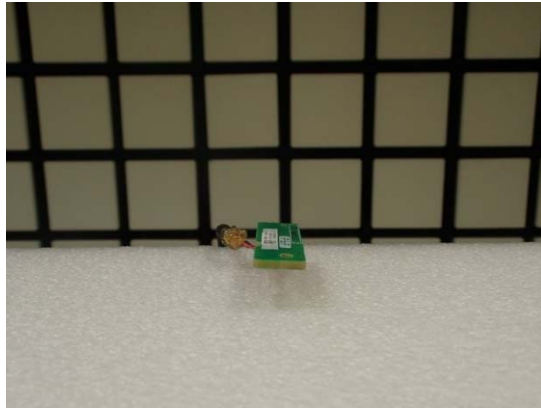
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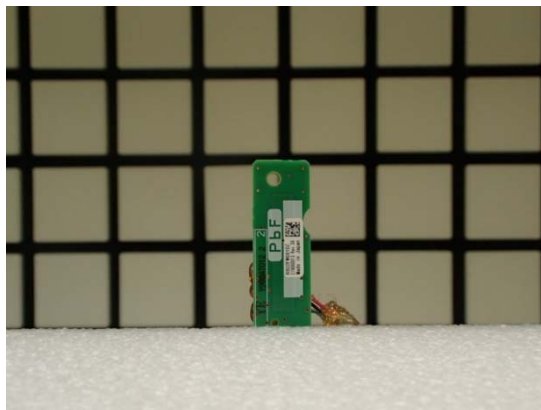
Worst Case Position

	Horizontal	Vertical
Spurious emission band edge compliance	X-axis	Y-axis
Spurious emission above 1GHz	X-axis	X-axis
Spurious emission below 1GHz	X-axis	Y-axis

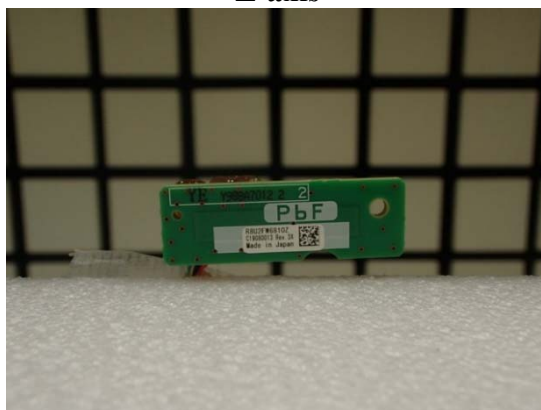
X-axis



Y-axis



Z-axis



End of Report

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